

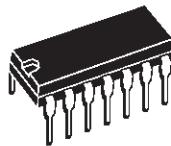
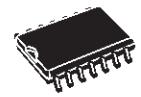
## QUAD 2-INPUT SCHMITT NAND GATE

- HIGH SPEED:  $t_{PD} = 20$  ns (TYP.) at  $V_{CC} = 4.5V$
- LOW POWER DISSIPATION:  
 $I_{CC} = 1 \mu A$  (MAX.) at  $T_A = 25^\circ C$
- OUTPUT DRIVE CAPABILITY  
 10 LSTTL LOADS
- HIGH NOISE IMMUNITY  
 $V_H$  (TYP.) = 0.71V AT  $V_{CC} = 4.5V$
- SYMMETRICAL OUTPUT IMPEDANCE:  
 $|I_{OH}| = I_{OL} = 4$  mA (MIN)
- BALANCED PROPAGATION DELAYS:  
 $t_{PLH} \approx t_{PHL}$
- PIN AND FUNCTION COMPATIBLE WITH  
 74 SERIES 132

### DESCRIPTION

The M74HCT132 is a high speed CMOS QUAD 2-INPUT SCHMITT NAND GATE fabricated in silicon gate C<sup>2</sup>MOS technology. It has the same high speed performance of LSTTL combined with true COMS low power consumption. Pin

### PRELIMINARY DATA


**B1R**

**M1R**

(Plastic Package)

(Micro Package)

**ORDER CODES :**

M74HCT132B1R

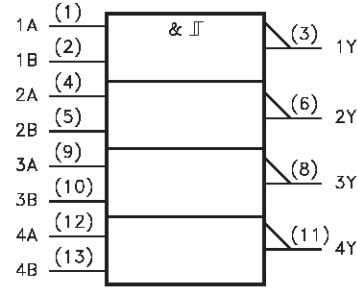
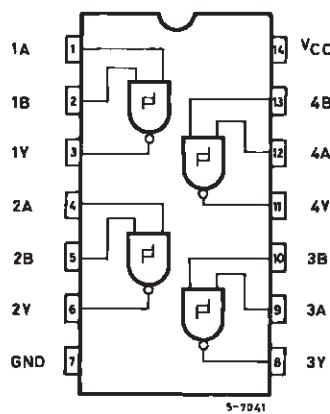
M74HCT132M1R

configuration and function are identical to those of the M74HCT00.

The hysteresis characteristics (around 15%  $V_{CC}$ ) of all inputs allow slowly charging input signals to be transformed into sharply defined jitter-free output signals.

All inputs are equipped with protection circuits against static discharge and transient excess voltage.

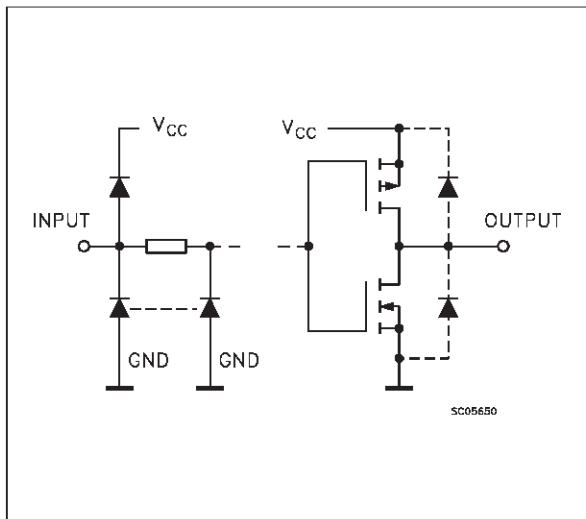
### PIN CONNECTION AND IEC LOGIC SYMBOLS



LC11020

## 74HCT132

### INPUT EQUIVALENT CIRCUIT



### PIN DESCRIPTION

PIN No	SYMBOL	NAME AND FUNCTION
1, 4, 9, 12	1A to 4A	Data Inputs
2, 5, 10, 13	1B to 4B	Data Inputs
3, 6, 8, 11	1Y to 4Y	Data Outputs
7	GND	Ground (0V)
14	V <sub>CC</sub>	Positive Supply Voltage

### TRUTH TABLE

A	B	Y
L	L	H
L	H	H
H	L	H
H	H	L

### ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V <sub>CC</sub>	Supply Voltage	-0.5 to +7.0	V
V <sub>I</sub>	DC Input Voltage	-0.5 to V <sub>CC</sub> + 0.5	V
V <sub>O</sub>	DC Output Voltage	-0.5 to V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	DC Input Diode Current	± 20	mA
I <sub>OK</sub>	DC Output Diode Current	± 20	mA
I <sub>O</sub>	DC Output Current	± 25	mA
I <sub>CC</sub> or I <sub>GND</sub>	DC V <sub>CC</sub> or Ground Current	± 50	mA
P <sub>D</sub>	Power Dissipation	500 (*)	mW
T <sub>stg</sub>	Storage Temperature	-65 to +150	°C
T <sub>L</sub>	Lead Temperature (10 sec)	300	°C

Absolute Maximum Ratings are those values beyond which damage to the device may occur. Functional operation under these condition is not implied.

(\*) 500 mW:  $\equiv$  65 °C derate 300 mW by 10 mW/°C: 65 °C to 80 °C

### RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Value	Unit
V <sub>CC</sub>	Supply Voltage	4.5 to 5.5	V
V <sub>I</sub>	Input Voltage	0 to V <sub>CC</sub>	V
V <sub>O</sub>	Output Voltage	0 to V <sub>CC</sub>	V
T <sub>op</sub>	Operating Temperature	-40 to +85	°C

## DC SPECIFICATIONS

Symbol	Parameter	Test Conditions		Value					Unit	
		V <sub>CC</sub> (V)		T <sub>A</sub> = 25 °C			-40 to 85 °C			
				Min.	Typ.	Max.	Min.	Max.		
V <sub>T+</sub>	High Level Threshold Voltage	4.5		1.2	1.55	1.9	1.2	1.9	V	
		5.5		1.4	1.75	2.1	1.4	2.1		
V <sub>T-</sub>	Low Level Threshold Voltage	4.5		0.5	0.85	1.2	0.5	1.2	V	
		5.5		0.6	1.1	1.4	0.6	1.4		
V <sub>H</sub>	Hysteresis Voltage	4.5		0.4	0.7	1.4	0.4	1.4	V	
		5.5		0.4	0.7	1.5	0.4	1.5		
V <sub>OH</sub>	High Level Output Voltage	4.5	V <sub>I</sub> <sup>(*)</sup> = V <sub>IL</sub> or V <sub>IH</sub>	I <sub>O</sub> =-50 μA	4.4	4.5	4.4		V	
		4.5		I <sub>O</sub> =-8 mA	4.18	4.31	4.13			
V <sub>OL</sub>	Low Level Output Voltage	4.5	V <sub>I</sub> <sup>(*)</sup> = V <sub>IH</sub>	I <sub>O</sub> =50 μA		0.0	0.1	0.1	V	
		4.5		I <sub>O</sub> =8 mA		0.17	0.26	0.33		
I <sub>I</sub>	Input Leakage Current	5.5	V <sub>I</sub> = 5.5V or GND			±0.1		±1.0	μA	
I <sub>CC</sub>	Quiescent Supply Current	5.5	V <sub>I</sub> = V <sub>CC</sub> or GND			1		10	μA	

(\*) All outputs loaded.

AC ELECTRICAL CHARACTERISTICS (C<sub>L</sub> = 50pF, Input t<sub>r</sub> = t<sub>f</sub> = 6 ns)

Symbol	Parameter	Test Condition		Value					Unit	
		V <sub>CC</sub> (V)		T <sub>A</sub> = 25 °C			-40 to 85 °C			
				Min.	Typ.	Max.	Min.	Max.		
t <sub>TLH</sub> t <sub>THL</sub>	Output Transition Time	4.5			7.0	15.0		19.0	ns	
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation Delay Time	4.5			20.0	33.0		41.0	ns	

(\*) Voltage range is 3.3V ± 0.3V

(\*\*) Voltage range is 5V ± 0.5V

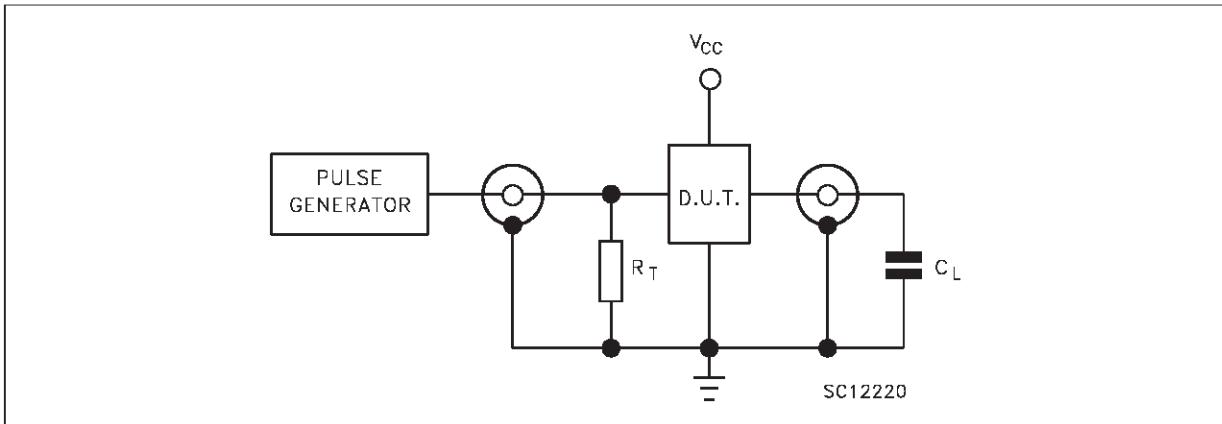
## CAPACITIVE CHARACTERISTICS

Symbol	Parameter	Test Conditions		Value					Unit	
		V <sub>CC</sub> (V)		T <sub>A</sub> = 25 °C			-40 to 85 °C			
				Min.	Typ.	Max.	Min.	Max.		
C <sub>IN</sub>	Input Capacitance				3.5				pF	
C <sub>PD</sub>	Power Dissipation Capacitance (note 1)				20				pF	

1) C<sub>PD</sub> is defined as the value of the IC's internal equivalent capacitance which is calculated from the operating current consumption without load. (Refer to Test Circuit). Average operating current can be obtained by the following equation. I<sub>CC(opr)</sub> = C<sub>PD</sub> • V<sub>CC</sub> • f<sub>IN</sub> + I<sub>CC</sub>/4 (per Gate)

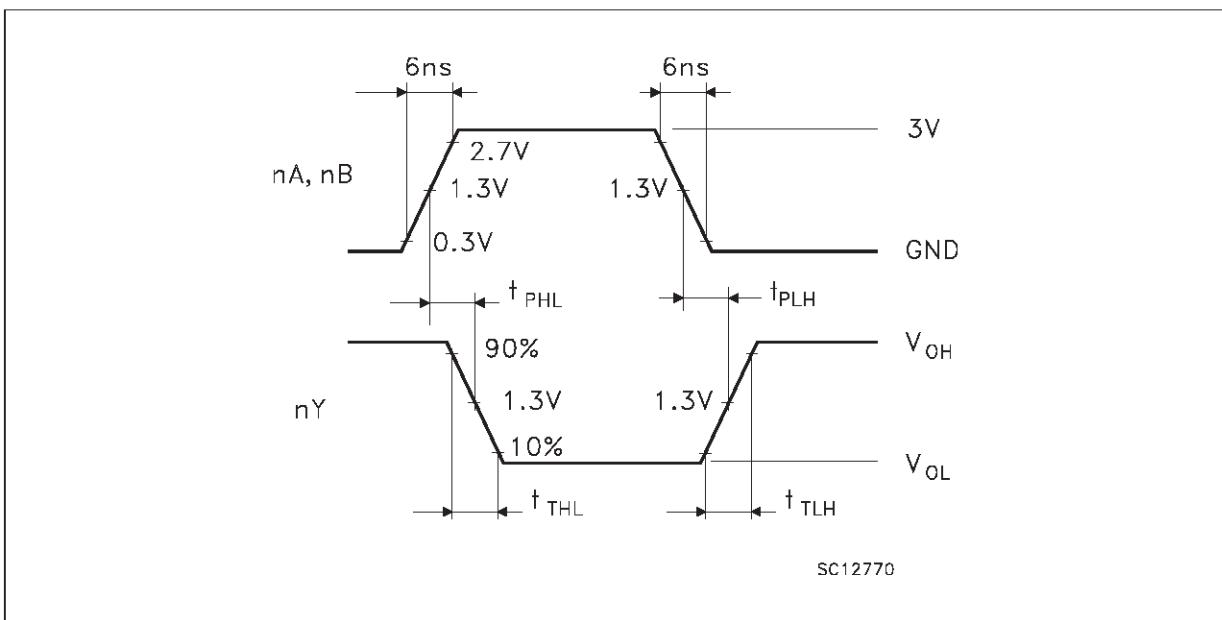
## 74HCT132

### TEST CIRCUIT



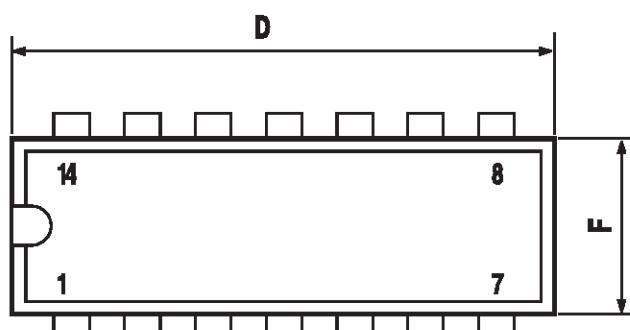
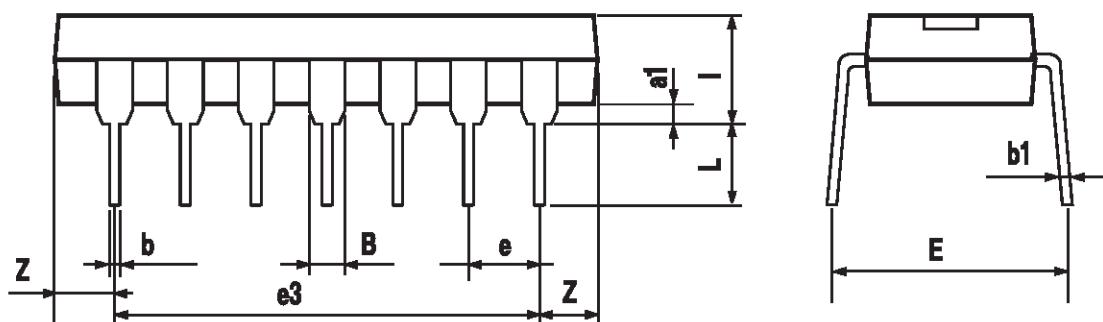
$C_L = 15/50 \text{ pF}$  or equivalent (includes jig and probe capacitance)  
 $R_T = Z_{\text{out}}$  of pulse generator (typically  $50\Omega$ )

### WAVEFORM: PROPAGATION DELAYS (f=1MHz; 50% duty cycle)



### Plastic DIP-14 MECHANICAL DATA

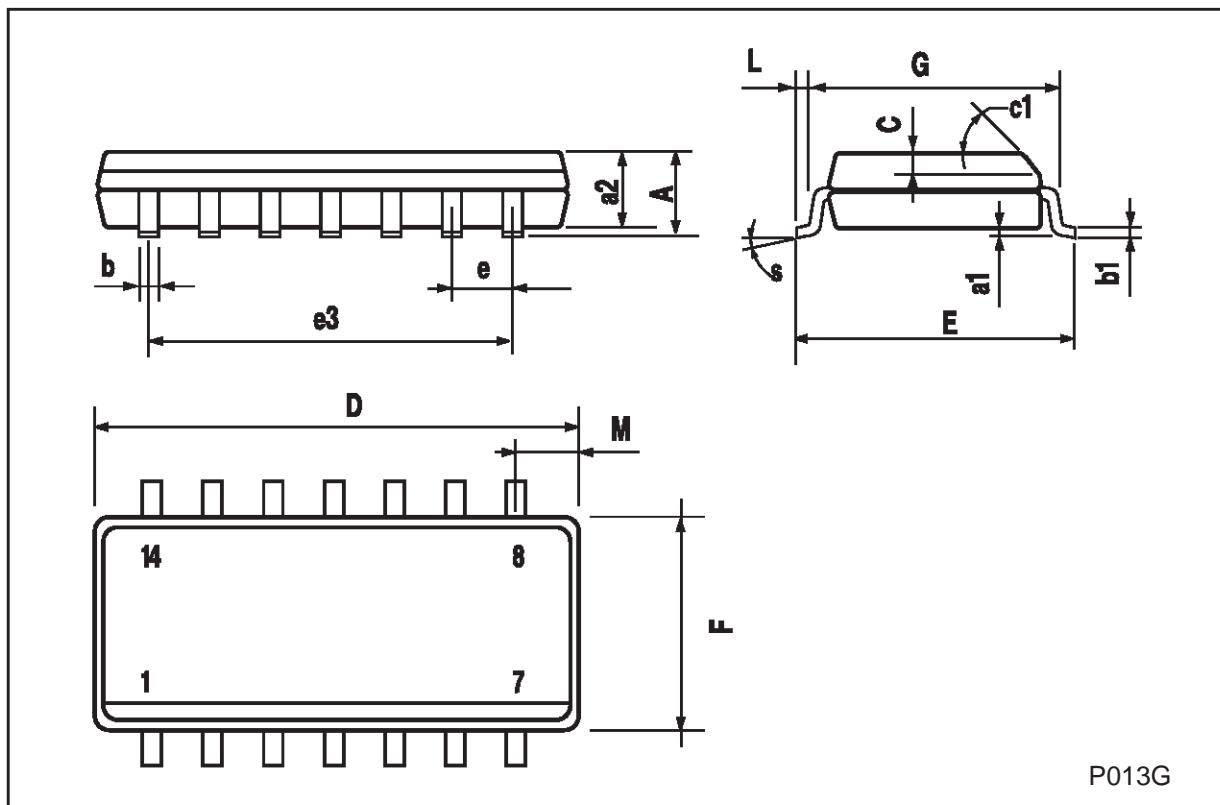
DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
a1	0.51			0.020		
B	1.39		1.65	0.055		0.065
b		0.5			0.020	
b1		0.25			0.010	
D			20			0.787
E		8.5			0.335	
e		2.54			0.100	
e3		15.24			0.600	
F			7.1			0.280
I			5.1			0.201
L		3.3			0.130	
Z	1.27		2.54	0.050		0.100



P001A

## SO-14 MECHANICAL DATA

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A			1.75			0.068
a1	0.1		0.2	0.003		0.007
a2			1.65			0.064
b	0.35		0.46	0.013		0.018
b1	0.19		0.25	0.007		0.010
C		0.5			0.019	
c1		45 (typ.)				
D	8.55		8.75	0.336		0.344
E	5.8		6.2	0.228		0.244
e		1.27			0.050	
e3		7.62			0.300	
F	3.8		4.0	0.149		0.157
G	4.6		5.3	0.181		0.208
L	0.5		1.27	0.019		0.050
M			0.68			0.026
S		8 (max.)				



Information furnished is believed to be accurate and reliable. However, STMicroelectronics assumes no responsibility for the consequences of use of such information nor for any infringement of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of STMicroelectronics. Specification mentioned in this publication are subject to change without notice. This publication supersedes and replaces all information previously supplied. STMicroelectronics products are not authorized for use as critical components in life support devices or systems without express written approval of STMicroelectronics.

The ST logo is a trademark of STMicroelectronics

© 1998 STMicroelectronics – Printed in Italy – All Rights Reserved  
STMicroelectronics GROUP OF COMPANIES

Australia - Brazil - Canada - China - France - Germany - Italy - Japan - Korea - Malaysia - Malta - Morocco - The Netherlands -  
Singapore - Spain - Sweden - Switzerland - Taiwan - Thailand - United Kingdom - U.S.A.